

IEC QUALITY ASSESSMENT SYSTEM (IECQ)

covering Electronic Components,
Assemblies, Related Materials and Processes

For rules and details of the IECQ visit www.iecq.org

Schedule of Scope to Certificate of Approval

Approved Process - Capability Approval

IECQ Certificate No.: C-IECQ BSI 14.0011
CB Certificate No.: E068/CA

Schedule Number: C-IECQ 14.0011-S Rev No.: 11 Revision Date: 2015/02/01

Issue	Date:	
1	30 October	2013
1	22 November	1995
1	03 March	1995
1	17 November	1993
	1 1 1 1 1	1 30 October 1 22 November 1 03 March

Packages and Sealing: 1) DIL, unencapsulated substrate, with up to 40 leads.

2) QIL metal cavity package, seam welded, up to 78 leads.

3) DIL metal cavity package, projection welded, up to 24 leads.

Boundaries of Capability:

Resistors: 3.5 ohms to 10M ohms.

Tolerance: $\pm 10\%$, $\pm 5\%$, $\pm 2\%$, $\pm 1\%$, ± 0.5 or $\pm 0.2\%$ dependent style of resistor.

Temperature Characteristic of

Resistance (absolute):

 ± 100 , ± 150 , -300/+150, ± 300 ppm/°C depending on resistor value

and temperature range used.

Temperature Characteristic of

resistance (tracking):

50 ppm/°C

Stability: \pm (0.5% +0.1 Ω) after 1000 hrs.

Operating temperature range:

-55°C to +125°C

Storage temperature range:

-65°C to +150°C package 2, 3.

Inspection and test: Full assessment.

Screening to customer specification.

This schedule is only valid in conjunction with the referenced Certificate of Approval
This approval and any schedule(s) may only be reproduced in full.
This approval is not transferable and remains the property of the issuing body.
The Status and authenticity of this approval and any schedule(s) may be verified by visiting the
Official IECQ Website. www.iecq.org

bsi.



IEC QUALITY ASSESSMENT SYSTEM (IECQ)

covering Electronic Components, Assemblies, Related Materials and Processes

For rules and details of the IECQ visit www.iecq.org

Schedule of Scope to Certificate of Approval Approved Process - Capability Approval

IECQ Certificate No.: C-IECQ BSI 14.0011
CB Certificate No.: E068/CA

Schedule Number: C-IECQ 14.0011-S Rev No.: 11 Revision Date: 2015/02/01

CECC 63 000	<u>Test</u>	<u>Conditions</u>	<u>Package</u>
4.5.8 (2)	Rapid change of temperature	-65 to 150°C	1, 2, 3
4.5.6	Vibration swept frequency	20 to 2,000Hz 196m/s²	1, 2, 3
4.5.4	Damp heat cyclic	28 cycles	1, 2, 3
4.5.11	Resistance to solder heat	350°C 3s	1, 2, 3
4.5.8 (3)	Rapid change of temperature	-40°C to +100°C	1, 2
4.5.15	Resistance to Solvent	Acetone, DI Water,ENVSolv-Ionic IPA	1, 2, 3
4.5.3	Damp heat steady state	21 days test Ca	2, 3
4.5.7	Acceleration, steady state	49,000m/s ²	2, 3
4.5.9	Sealing fine and gross leak		2,3
	Electrical performance:	To customer detail specification.	
	Customer participation in design:	Any degree by agreement	t

This schedule is only valid in conjunction with the referenced Certificate of Approval
This approval and any schedule(s) may only be reproduced in full.
This approval is not transferable and remains the property of the issuing body.
The Status and authenticity of this approval and any schedule(s) may be verified by visiting the
Official IECQ Website. www.iecq.org

